

Multilayer Ceramic Chip Capacitors

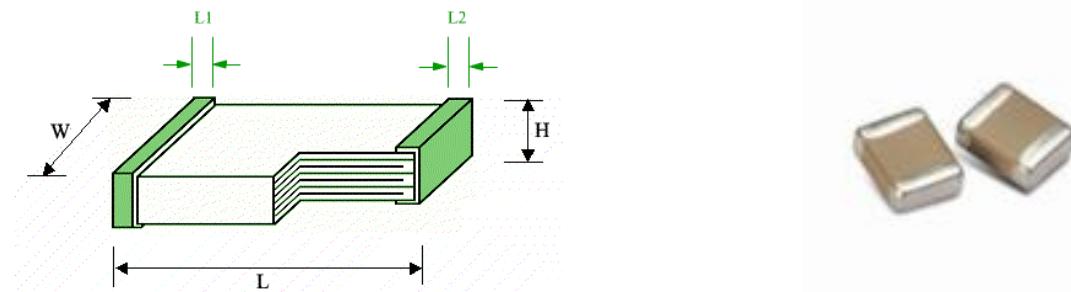
Multilayer Ceramic Chip Capacitors

Middle & high voltage MLCC is a kind of special design , special technology MLCC that bases on the technology of general MLCC. This kind of MLCC has stable high voltage reliability and suitable to SMT. Middle & high MLCC is widely applicable for many direct high voltage circuits in which it can improve the performance of the circuit.

Features

- Series size from 0603~2225
- Working Voltage from 100V~5000V
- Surface mount suited for wave and reflow soldering
- Wide Operating temperature range from -55°C-125°C
- Good Temperature Coefficient
- High reliability

Dimension



How To Order

HC	1206	X7R	105	K	500	P
Product Code	Size Ex.: 0603	Dielectric Ex.: COG=NPO	Capacitance Unit : pF	Tolerance Ex.: A=± 0. 1pF	Rated Voltage Ex.: 6R3=6. 6V	Termination P:Ag/Ni/Sn S:Ag/Pd/Pt
HV=High Voltage	0805	X7R	Ex.: 0R5=0. 5pF	B=± 0. 2pF	500=50V	
Capacitance HA=Safety Capacitors	1206	X5R	2R5=2. 5pF	C=± 0. 25pF	102=1000V	
1210	Y5V	2R5=2. 5pF	105=10×10 ⁵	D=± 0. 5pF	202=2000V	
1808	Z5U	105=10×10 ⁵		F=± 1%	502=5000V	
1812				G=± 2%		
2220				J=± 5%		
2225				K=± 10%		
				M=± 20%		
				Z=+80%/-20%		

Multilayer Ceramic Chip Capacitors

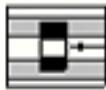
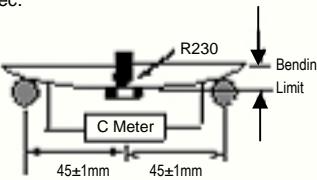
Capacitance Range

Size Inch (mm)	Rated Voltage	Capacitance Range			
		COG (nF)	X5R (nF)	X7R (nF)	Y5V (nF)
0402 (1005)	6.3V		1,000~2,200 (225)	1,000 (105)	1,000 (105)
	10V		1,000 (105)	100 (104)	1,000 (105)
	16V		1,000 (105)	100 (104)	
0603 (1608)	6.3V	1~22 (223)	1,000~10,000 (106)	1,000~2,200 (225)	1,000~4,700 (475)
	10V	1~10 (103)	1,000~4,700 (475)	1,000~2,200 (225)	1,000~4,700 (475)
	16V	1~3.3 (332)	1,000~2,200 (225)	1,000 (105)	1,000~2,200 (225)
	25V	1~3.3 (332)	1,000 (105)		1,000 (105)
0805 (2012)	6.3V		1,000~47,000 (476)	1,000~10,000 (106)	1,000~22,000 (226)
	10V	1~100 (104)	1,000~22,000 (226)	1,000~10,000 (106)	1,000~10,000 (106)
	16V	1~33 (333)	1,000~10,000 (106)	1,000~4,700 (475)	1,000~10,000 (106)
	25V	1~22 (223)	1,000~4,700 (475)	1,000 (105)	1,000~4,700 (475)
	50V	1~10 (103)	1,000 (105)	1,000 (105)	1,000~2,200 (225)
1206 (3216)	6.3V		1,000~10,000 (107)		1,000~100,000 (107)
	10V		1,000~47,000 (476)	1,000~22,000 (226)	1,000~47,000 (476)
	16V	10~100 (104)	1,000~22,000 (226)	1,000~10,000 (106)	1,000~22,000 (226)
	25V	10~47 (473)	1,000~10,000 (106)	1,000~10,000 (106)	1,000~10,000 (106)
	35V		1,000~4,700 (475)	1,000~4,700 (475)	1,000~10,000 (106)
	50V	1~33 (333)	1,000~4,700 (475)	1,000~4,700 (475)	1,000~10,000 (106)
1210 (3225)	6.3V		1,000~100,000 (107)		1,000~100,000 (107)
	10V		1,000~47,000 (476)	1,000~47,000 (476)	1,000~47,000 (476)
	16V		1,000~47,000 (476)	1,000~22,000 (226)	1,000~47,000 (476)
	25V	10~100 (104)	1,000~22,000 (226)	1,000~10,000 (106)	1,000~22,000 (226)
	35V		1,000~10,000 (106)	1,000~10,000 (106)	1,000~10,000 (106)
	50V	10~47 (473)	1,000~10,000 (106)	1,000~10,000 (106)	1,000~10,000 (106)
1812 (4532)	6.3V		1,000~100,000 (107)		1,000~100,000 (107)
	10V		1,000~100,000 (107)	1,000~47,000 (476)	1,000~100,000 (107)
	16V	10~220 (224)	1,000~47,000 (476)	1,000~47,000 (476)	1,000~47,000 (476)
	25V	10~120 (124)	1,000~22,000 (226)	1,000~22,000 (226)	1,000~22,000 (226)
	50V	10~100 (104)	1,000~10,000 (106)	1,000~10,000 (106)	1,000~10,000 (106)
2220 (5750)	6.3V		1,000~100,000 (107)		
	10V		1,000~100,000 (107)		
	16V		1,000~47,000 (476)	1,000~47,000 (476)	1,000~100,000 (107)
	25V		1,000~22,000 (226)	1,000~22,000 (226)	1,000~47,000 (476)
	50V		1,000~10,000 (106)	1,000~10,000 (106)	1,000~22,000 (226)

※ We can design according to customer special requirements.

Multilayer Ceramic Chip Capacitors

HV Series Specification & Test Condition

Item	Specification	Test Condition		
Operation Temperature	-55 to +125°C			
Visual	No abnormal exterior appearance	Visual Inspection		
Capacitance	Within The Specified Tolerance	Class	Frequency	Voltage
Quality Factor	Class I (NPO): More Than 30pF : $Q \geq 1000$ 30pF & Below: $Q \geq 400 + 20C$ (C:Cap., pF)	NPO $C \leq 100pF$ $C > 100pF$	1MHz±10% 1KHz±10%	1.0±0.2VRms
		X7R	1KHz±10%	1.0±0.2VRms
Dissipation Factor	Class II (X7R): Maximum 0.025	Perform a heat temperature at 150±5°C for 30min. then place room temp. for 24±2hr.		
Insulation Resistance	10,000MΩ or 500/C Ω whichever is smaller. (C in Farad)	V≤500V, Rated Voltage V>500V, Applied 500Vdc Charge Time : 60sec. Is applied less than 50mA current.		
Withstanding Voltage	No dielectric breakdown or mechanical breakdown	200V≤V<500V : 200% Rated Voltage 500V≤V<1000V: 150% Rated Voltage 1000≤V : 120% Rated Voltage for 1~5 sec. Current is limited to less than 50mA.		
Withstanding voltage testing requires immersion of the element in a isolation fluid prevent arcing on the chip surface, at voltage over 1000Vdc.				
Temperature Capacitance Coefficient	Char. NPO(N) X7R (X)	Temp. Range -55°C ~ +125°C -55°C ~ +125°C	Cap. Change ± 30ppm/°C ± 15%	Class I: [C2-C1/C1(T2-T1)] × 100% Class II: (C2-C1)/C1 × 100% T1:Standard Temperature(25°C) T2:Test Temperature C1:Capacitance At Standard Temperature C2:Capacitance At Test Temperature
Adhesive Strength of Termination	No indication of peeling shall occur on the terminal electrode.	 A 5N·f ($\approx 0.5\text{Kg} \cdot \text{f}$) pull force shall be applied for 10±1 sec.		
Resistance to Flexure of Substrate	No mechanical damage or capacitance change more than the following table.	 The board shall be bend 1.0mm with a rate of 1.0 mm/sec.		
Solderability	More than 90% of the terminal surface is to be soldered newly, so metal part does not come out or dissolve .	 Solder Temperature : 245±5°C Dip Time : 5 ± 0.5 sec. Immersing Speed : 25±10% mm/s Solder : H63A Flux : Rosin Preheat : At 80~120 °C For 10~30sec.		

HV Series Specification & Test Condition

Item	Specification		Test Condition														
Resistance to Soldering Heat	Appearance	No mechanical damage shall occur	Class II capacitor shall be set for 48±4 hours at room temperature after one hour heat treatment at 150 +0/-10°C before initial measure.														
	Capacitance	Class I (NPO): Within 2.5% or ±0.25pF whichever is larger of initial value Class II (X7R): Within ±10% of initial value	Preheat : at 150±10°C for 60~120sec. Dip : solder temperature of 260±5°C Dip Time : 10 ± 1sec. Immersing Speed : 25±10% mm/s														
	Q / Tanδ	To satisfy the specified initial value	Solder : H63A Flux : Rosin														
	Insulation Resistance	To satisfy the specified initial value	Measure at room temperature after cooling for Class I : 24 ± 2 Hours Class II : 48 ± 4 Hours														
Temperature Cycle	Appearance	No mechanical damage shall occur	Class II capacitor shall be set for 48±4 hours at room temperature after one hour heat treatment at 150 +0/-10 °C before initial measure.														
	Capacitance	Class I (NPO): Within 2.5% or ±0.25pF whichever is larger of initial value Class II (X7R): Within ±7.5% of initial value	Capacitor shall be subjected to five cycles of the temperature cycle as following:														
	Q / Tanδ	To satisfy the specified initial value	<table border="1"> <thead> <tr> <th>Step</th><th>Temp.(°C)</th><th>Time(min)</th></tr> </thead> <tbody> <tr> <td>1</td><td>Min Rated Temp.+0/-3 (-55)</td><td>30</td></tr> <tr> <td>2</td><td>25</td><td>3</td></tr> <tr> <td>3</td><td>Max Rated Temp.+3/-0 (125)</td><td>30</td></tr> <tr> <td>4</td><td>25</td><td>3</td></tr> </tbody> </table>	Step	Temp.(°C)	Time(min)	1	Min Rated Temp.+0/-3 (-55)	30	2	25	3	3	Max Rated Temp.+3/-0 (125)	30	4	25
Step	Temp.(°C)	Time(min)															
1	Min Rated Temp.+0/-3 (-55)	30															
2	25	3															
3	Max Rated Temp.+3/-0 (125)	30															
4	25	3															
Insulation Resistance	To satisfy the specified initial value	Measure at room temperature after cooling for Class I : 24 ± 2 Hours Class II : 48 ± 4 Hours															
Humidity	Appearance	No mechanical damage shall occur	Class II capacitor shall be set for 48±4 hours at room temperature after one hour heat treatment at 150 +0/-10 °C before initial measure.														
	Capacitance	Class I (NPO): Within 5% or ±0.5pF whichever is larger of initial value Class II (X7R): Within ±15% of initial value	Temperature : 40± 2 °C Relative Humidity : 90 ~95%RH Test Time : 500 +12/-0 hr														
	Q / Tanδ	Class I (NPO): More Than 30pF : Q ≥350 30pF & Below: Q≥275+2.5C Class II (X7R): Maximum ±5.0%	Measure at room temperature after cooling for Class I : 24 ± 2 Hours Class II : 48 ± 4 Hours														
	Insulation Resistance	1,000MΩ or 50/C Ω whichever is smaller. (C in Farad)															

HV Series Specification & Test Condition

Item	Specification		Test Condition
High Temperature Load (Life Test)	Appearance	No mechanical damage shall occur	Class II capacitors applied DC voltage (following table) is applied for one hour at maximum operation temperature $\pm 3^{\circ}\text{C}$ then shall be set for 48 ± 4 hours at room temperature and the initial measurement shall be conducted. Applied Voltage :
	Capacitance	Class I (NPO): Within 3% or $\pm 0.3\text{pF}$ whichever is larger of initial value Class II (X7R): Within $\pm 15\%$ of initial value	
	Q / Tan δ	Class I (NPO): More Than 30pF : $Q \geq 350$ 30pF & Below: $Q \geq 275 + 2.5C$ Class II (X7R): Maximum $\pm 5\%$	
Vibration	Insulation Resistance	1,000M Ω or $50/C \Omega$ whichever is smaller. (C in Farad)	Temperature : max. operation temperature Test Time : $1000 + 12/-0\text{Hr}$ Current Applied : 50 mA Max. Measure at room temperature after cooling for Class I : 24 ± 2 Hours Class II : 48 ± 4 Hours
	Appearance	No mechanical damage shall occur	Solder the capacitor on P.C. board.
	Capacitance	Within the specified tolerance	Vibrate the capacitor with amplitude of 1.5mm P-P changing the frequencies from 10Hz to 55Hz and back to 10Hz in about 1 min. Repeat this for 2 hours each in 3 perpendicular directions.
	Q / Tan δ	To satisfy the specified initial value	